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Introduction

The X-ray Lasers and Coherent X-ray Sources: Development and Applications conference held in San Diego, California on 23–25 August, 2011, continues the series of meetings over the last two decades dedicated to new developments and applications of x-ray lasers and other coherent x-ray sources. The scope of this meeting was to present state-of-the-art results in the generation of intense x-rays in areas of plasma-based x-ray lasers, 4th generation accelerator-based sources and higher order harmonic (HOH) generation.

Although this has been the conference objective in recent meetings, this year the conference title was changed from the previous Soft X-ray Laser and Applications VIII meeting, held in 2009. The intent was to enhance the goal to bring different communities working in plasma-based x-ray lasers and sources, HOH and free electron laser (FEL) research together in areas of overlap and common interest: applications to ultrafast, high-intensity interaction with matter, innovative instrumentation for optics and detectors, or modeling and theory. This volume reviews the state of the field in 2011.

There were new and exciting presentations in the eight oral and extended poster sessions addressing the main research themes of Free Electron Lasers, Seeding of X-ray Lasers, Harmonics and Short Wavelength Lasers, X-ray Laser Applications and Plasma-based X-ray Laser Sources. In the Free Electron Lasers sessions, the first demonstration of the inner shell photo-ionized x-ray laser scheme, first proposed in 1967, was shown for neon Kα. This is an extraordinary result for a scheme that has eluded researchers for many decades. This gives insight into the kinetics of this high-efficiency pumping scheme that will lead to future experiments scaled to higher Z and 2-color irradiation. Many new Linac Coherent Light Source experiments were reported producing data from the recently commissioned end stations. These included new results showing lensless imaging of biological samples at hard x-ray energies.

The Seeding of X-ray Lasers topic, where a HOH seed is wavelength-matched and injected into a plasma amplifier, continues to be of strong interest. New modeling results with supporting experiments to better characterize and understand the scheme were reported by several groups. An advanced scheme of chirped pulse amplification of an x-ray laser was proposed to increase output to milli-joules in ultrafast ~200 fs duration. HOH source development was reported in Harmonics and Short Wavelength Lasers using relativistic laser intensities into a gas jet. Applications to attosecond physics as well as advances in lensless, nanoscale imaging were described.
In the various X-ray Lasers Applications sessions, there were overlaps and links developing in the science communities where similar types of experiments were proposed for use on FELs, x-ray lasers and HOH sources. Lensless imaging has been mentioned for FELs and HOHs. Others included opacity measurements, warm dense matter and high energy density plasma creation experiments. Notable results were presented using novel soft x-ray laser-ablated nanoscale mass spectroscopy techniques demonstrated in two dimensions with high sensitivity. New results and refinements were presented in high-resolution microscopy, imaging, material properties as well as measuring time-resolved dynamic changes in matter.

Plasma-based X-ray Laser Sources continue to make progress to shorter wavelengths and higher repetition rates with substantially lower pump energies. Results for saturated x-ray lasers, operating at 8 nm, were reported by several groups. Coherence and characterization experimental results were described that will enhance the continued development.

We gratefully acknowledge the continued support of SPIE for the field of x-ray lasers. We thank SPIE for the outstanding organization of the conference at all stages as well as the considerable efforts of the staff towards the publication of the proceedings volume. We would like to thank the Program Committee for their support and guidance and to the session chairs for their help in the running of the conference. We give our thanks to the many participants for their high quality scientific contributions to the 2011 meeting.

James Dunn
Annie Klisnick
BIOMEDICAL SPECTRAL X-RAY IMAGING; PROMISES AND CHALLENGES

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ABSTRACT
Imaging arrays with sub-millimeter detector pixels that count and allocate energy to each detected photon are now being introduced into biomedical computed tomography scanners. Consequently, bremsstrahlung x-ray can provide the advantages of simultaneous recording of multiple quasi-monochromatic x-ray images which can be used for identification of various materials within the image field. This capability increases the inherent contrast within biomedical CT images and also introduces the ability to use high atomic weight “foreign” elements (e.g., strontium) which are surrogates for “native” biological elements (e.g., calcium) to monitor tissue function (e.g., bone deposition). Challenges for this methodology include limited maximum fluence due to photon pile-up, charge-sharing between contiguous pixels and heterogeneous pixel characteristics due to manufacturing difficulties.

Keywords: Dual-Energy X-ray, Micro-CT, Clinical CT, X-ray Scatter, Photon Counting, Beam Hardening, Photon Pile-up, Charge sharing, Kedge, X-ray fluorescence

1. INTRODUCTION
Spectral x-ray imaging involves allocating the photon energy to each photon detected. Consequently, photon counting is an integral component of this approach. Spectral tomographic imaging has been used for decades in nuclear imaging in which different monochromatic gamma rays are distinguished so that Compton scatter (which has lower photon energy than the monochromatic gamma ray generated by the radionuclide) can be separated from the gamma ray of interest.1 It has also been used in dual energy x-ray CT imaging for enhancing the contrast of elements with a K absorption edge (Figure 1).2

However, as illustrated in Figure 2, it’s important to note that up to now the dual energy x-ray subtraction imaging involved broad spectrum x-ray and did not involve photon counting. The major x-ray CT companies are marketing clinical CT scanners which can utilize dual energy subtraction for separation of the iodine in intravascular contrast agent from calcium accumulations in diseased arterial vessel walls or discriminate different material contents of kidney stones and tissue deposits such as occur in gout.4,5 The Siemens scanner6 achieves this by use of two x-ray sources with one operating at up to 140 kVp and a tin filter and the other tube operated at lower voltage, e.g., 80 kVp. The Philips scanner7 uses a single x-ray source with a dual layer detector array in which the detector material in the...
superficial array is selected for capturing low energy photons and the deep array selected for capturing the high energy photons.

An improvement to this approach was implemented in x-ray imaging such as mammography and micro-CT which utilize lower photon energies. Figure 3 shows that the bandwidth of the bremsstrahlung can be greatly narrowed by use of the Kα emission of a selected metal in the x-ray source’s anode along with a metal foil filter with a Kedge just above the Kα of the anode.

Figure 2 - Left panel shows a typical x-ray spectrum of a clinical CT scanner’s x-ray source operated at 80 and 140 kVp. These sources were both filtered with a layer of aluminum. Note the considerable overlap of the two spectra. The right panel shows the two spectra with the 140 kVp spectrum after filtration through various thin, fairly high atomic weight, metal foils. Reproduced with permission from Ref 3.

An improvement to this approach was implemented in x-ray imaging such as mammography and micro-CT which utilize lower photon energies. Figure 3 shows that the bandwidth of the bremsstrahlung can be greatly narrowed by use of the Kα emission of a selected metal in the x-ray source’s anode along with a metal foil filter with a Kedge just above the Kα of the anode.

Figure 3 - Three x-ray spectra generated with anodes made of copper, molybdenum and silver. These metals have Kα fluorescence peaks at 8.03&8.05 keV for copper, 17.4&17.5 keV for molybdenum and 22.16 &21.99 keV for silver. When these spectra are filtered by a foil of nickel (Kedge 8.3keV), zirconium (Kedge 18.0 keV) or palladium (Kedge 24.4 keV) respectively much of the spectrum above and below the Kα peak is preferentially suppressed leaving these quasi-monochromatic x-ray spectra. Reproduced with permission from Ref. 9.

The advantage of this approach is that there is greatly reduced beam hardening (i.e., the spectral content of penetrating x-ray shifts to higher energies with increasing thickness of the transilluminated object. In CT beam hardening results in the “cupping” artifact in which the CT image grey scale varies with location within an object of uniform attenuation coefficient. These clinical and micro-CT approaches, however, do not fully exploit the power of spectral imaging because the bandwidth of the x-ray spectra used are still quite broad. Importantly, synchrotron x-ray imaging methods (which has sufficiently high flux to allow imaging at very narrow (e.g., 50 eV) bandwidth)11) are limited by the fact that they typically do not count photons. Counting photons is important because it reduces the quantum noise to that of the detected photons and eliminates electronic noise of the imaging detector system.12
In recent years detector arrays have been developed that have x-ray photon counting and energy discriminating capabilities. This development now opens the door to fully exploiting spectral x-ray imaging capabilities for high spatial resolution x-ray imaging. The following description of one such imaging array illustrates the potential and technical challenges associated with this approach.

2. SPECIFIC METHODOLOGY

2.1 Methodological difficulties

Figure 4 is a schematic of the Medipix x-ray detection array developed at CERN. It shows a layer of material (silicon in this example) which captures x-ray photons and transports the resulting shower of electrons to the deeper surface by virtue of the potential gradient imposed across the material. The number of electrons in that shower being proportional to the x-ray photon energy.

Figure 4 – Left upper panel is a schematic representation of a Medipix chip and its components. See text for details. Right upper panel is a magnified view of one of the 55x55µm² CMOS circuits underlying each detector “pixel”. The left lower panel is a schematic representation of the bump bond between the x-ray-to-electron converting material and the CMOS circuitry. The right lower panel shows the absorption efficiency of several candidate material for converting the x-ray to electrons. (Right upper panel reproduced with permission from Ref. 14. Lower panels, courtesy from Dr. A. P. Butler, Univ. Canterbury, Christchurch NZ).
2.1.1 Charge sharing

As illustrated in Figure 5 the charge cloud generated by the x-ray photon is sensed by one or several contiguous CMOS circuits in a 256x256 array beneath the layer. This circuit counts the number of clouds that fall above the program-selectable energy threshold and converts their charge to cm index of photon energy. These data are stored in a memory with a capacity for the information about 8000 photons.

The Medipix3 detector array’s CMOS circuit also “look” at their contiguous neighbors to see if there is coincident detection of photons. This is important as the cloud of electrons may fall on adjacent pixels.

If taken at face value this would result in several lower energy photons being detected. The CMOS circuit determines that they are from one photon, thus by adding the values and allocating the sum to the pixel with the highest number of electrons, deals with this charge sharing problem. Figure 6 illustrates the impact of this capability.

Figure 6 – Left panel shows the green plot spectrum recorded with the Medipix3 chip of a palladium 103 source which generates predominantly 20 keV gamma rays and the right panel shows the green plot spectrum of an iodine 125 source which predominantly generates 27keV gamma rays. Note, the “shoulder” of low energy photons which result from the charge-sharing artifact of the chip operated in the “single pixel mode”. The black spectra are those generated when the chip is operated in the “charge summing mode”. The abscissa’s scale is in analog to digital units, which can be calibrated from these gamma ray emission responses.
2.1.2 Charge ‘pile-up’

Another issue is the problem of charge pile-up\textsuperscript{15,16} in which two photons strike a pixel simultaneously and thus are detected as a single photon with the energy equal to the sum of the two photons. Figure 7 illustrates the impact of the pile-up phenomenon. In addition to reporting fewer photons than actually arrive at the detector, there is a skewing from lower to higher photon energies in the reported spectrum. This can only be corrected at the CMOS level by making it faster or by reducing the size of the detector pixel. Consequently, we deal with this by reducing the rate of photon delivery to a level at which the pile up effect is negligible. Pile-up and charge sharing have opposite consequences. Pile-up is reduced with small detector pixels but charge sharing decreases with increased pixel size. Hence, pixel size must be matched to the imaging application.

Figure 7 – Each of these curves was generated by exposing the chip to a constant number of photons, but at increasing rates of delivery by decreasing the distance of the x-ray source to the detector array and by proportionately reducing the time interval over which they were delivered. If there was no photon “pile-up” the number of photons detected should remain constant at all exposure rates, but as illustrated here the number detected decreased if those photons were delivered in less than 1 second under these exposure conditions. As the x-ray source current was increased we see a proportional increase in the number of photons detected and an appearance of the pile-up effect at lower exposure rates.

Figure 8 shows that increasing pile-up, resulting from increasing rate of delivery of photons caused by increased current in the x-ray source, results in skewing to the right of the x-ray spectrum measured with the silicon-based MPX3 imaging array.

2.1.3 Non uniform pixel sensitivity

Another technical issue is the heterogeneity of the individual pixel characteristic exposure to signal output curve. Ideally this input/output relationship is linear until it saturates beyond the capacity of the counter in the CMOS circuit. However due to manufacturing imperfections, the sensitivity of each pixel differs so that some saturate earlier than others when exposed to the same x-ray flux. Figure 9 shows that with increasing exposure the average signal from the array “plateaus” as more and more pixels reach their individual plateaus. However, if we expose the array in time slots that expose even the “weakest” pixels to just below the “knee” of their input/output curve, and repeat those exposures...
after downloading after each exposure, we can get the linear relationship at increased exposure by summing those exposures.

![Graph showing photon count over exposure time](image1)

**2.1.4 Detector fluorescence**

Finally, there is the problem of fluorescence and x-ray scatter with the detector material.\textsuperscript{16} Silicon, Gallium and Arsenic have fluorescence energies below 10 keV and hence are not of concern in micro-CT, mammography or clinical CT. However, Cadmium and Tellurium have fluorescence at about 23 and 27 keV, values which could significantly distort the photon energy information in micro-CT and mammography, but probably not significantly in clinical CT.

**2.2 Applications**

An immediate consequence of energy resolving x-ray imaging is the ability to eliminate the beam hardening artifact in CT. Figure 10 is a plot of CT image pixel grey-scale values along a diameter through a test phantom. If the full spectral width is used we get the “cupped” profile whereas if we used just a narrow bandwidth selected from that same exposure the “cupping” artifact is essentially eliminated. Note the increased noise in that profile – consistent with the fewer photons in the narrow bandwidth spectrum used in generating this tomogram. However, if we were to do a CT reconstruction for each of the multiple energy bins within that broad spectrum, and then added those images then the “cupping” artifact would still be eliminated and the noise would be essentially the same as the single broad spectrum data.

![Graph showing CT value profile over exposure](image2)

**Figure 9** The black curve indicates the impact of the heterogeneity of detector pixel saturation exposure as a function of total exposure. The red curve shows that if the same data are collected piecewise with a sequence of short-duration exposures, then the expected linear relationship results. See text for details.

**Figure 10** The green profile is a CT value profile along a diameter of a plexiglas test phantom scanned with broad spectrum x-ray. It shows the cupping artifact due to beam hardening. The red profile is from the same diameter of the phantom, but from a CT image generated with the narrow bandwidth section selected from the broad spectrum scan data set. Note, the great reduction in beam hardening artifact and the increased noise (due to the fewer photons).
Figure 11 illustrates the impact of multi-energy imaging on the ability to identify the signal due to an element with a K-edge within the range of the spectrum. In this case rubidium, with a K-edge at 15 keV, the characteristic increase in CT grey scale values as the photon energy increases through the K edge energy. In this case it identifies and discriminates the rubidium from potassium. A possible importance here is that rubidium is a biological surrogate for potassium and hence muscle cell activity could be monitored by quantitating the amount of rubidium incorporated into muscle, a mechanism used previously using NMR spectroscopy scans to measure the uptake or washout of 87 Rb.17

An exciting development is the use of gold-labeled nano-spheres, that are attached to antibodies targeted to specific cell types, which can be injected into the blood stream and then depositing preferentially in tissues such as cancer.19 The high attenuation coefficient of gold, combined with its K absorption edge of 80.7 keV, allows detection and discrimination from other sources of local increase in CT grey-scale value even at relatively low concentrations of the nano-spheres in the tissue. However, the concentration of the nano-spheres should exceed a certain minimum in order to prevent loss of specificity due to the partial volume effect resulting from CT image voxels being too large relative to the number of nano-spheres per voxel. Figure 12 illustrates this effect with a single gold-coated 15 micrometer diameter micro-sphere, in water, imaged at different voxel sizes.

Figure 11 – Upper left panel is a schematic of the contents of a plexiglas test phantom containing samples of potassium and rubidium chloride solutions of different concentrations. 145 milli-equivalent is the intracellular concentration of potassium. The right upper panels show the quasi monochromatic CT images generated at increasing x-ray photon energy. The left lower panel shows the measured CT values and how these change with x-ray photon energy. The right lower panel uses the NIST18 K-edge of rubidium and how this information is conveyed by the 3 keV-wide spectral “bins” used in this study. The loss of the clear K-edge results from the spectral width, but the attenuation decay as a function of increasing photon energy for rubidium clearly allows it to be distinguished from the potassium.

Figure 12 - a bar graph of the CT grey-scale values of a single voxel containing a 15 micrometer diameter, gold coated micro-sphere. If the micro-sphere were solid gold then detection of the microsphere in a larger voxel size would still be possible.
Spectral imaging also has potential for greatly facilitating x-ray scatter imaging. Coherent x-ray scatter (as distinct from incoherent – i.e., Compton- scatter) can provide information about chemical bonds and of some repetitive submicron anatomical features. Figure 13 shows how this involves recording the x-ray scatter at several angles of view away from the illuminating x-ray beam over a range of 0 to 20 degrees. Hence, a CT scan would involve rotation through 360 degrees using a single slice exposure. If bremsstrahlung is used the scatter recorded at each pixel will have multispectral information as well as being the integral of the scatter generated along a chord of the illuminated object cross section.

Figure 13 - A schematic of how a clinical multi-slice CT scanner can be converted to a single slice coherent x-ray scatter detection scanner. Reproduced with permission Ref. 20.

Figure 14 shows that if an energy discriminating detector is used, combined with a polycapillary x-ray optic collimator, then all necessary information can be recorded from one angle of view – the spectral information now providing the equivalent of the angle in the arrangement illustrated in Figure 13.

Figure 14 - A schematic of a planar x-ray exposure (seen edge on) and the scatter from that plane being observed via a collimator held at a fixed angle to the x-ray plane. The right panel shows how the spectral energy values can be used to generate the momentum transfer function for the material of lucite. The red profile was generated with the spectral imaging array at one angle and the black profile was generated with multi-angular data without energy discrimination. Modified and reproduced with permission from Ref. 22.

3. DISCUSSION

The overview of capabilities and technical challenges listed above suggests that the introduction of spectral x-ray imaging in clinical CT has potential for increasing the CT image contrast, signal to noise, accuracy of CT grey-scale values, and ability to identify and/or discriminate elements. This will expand the use of CT beyond the current anatomic information to increase the repertoire of functional information. Examples of the latter include quantitation of iron content in livers in hemachromatosis, discriminating iodine (in contrast agent) in arterial lumens from calcium in the arterial walls, and iron from calcium in arterial walls in atherosclerotic plaques. With this capability there will be stimulus for developing contrast agents based on lanthanide elements with K edges in the clinical kV ranges. Consequently multiple contrast agents could be used simultaneously for use in dual indicator dilution techniques such as blood pool versus contrast excreted via the kidney or bile or diffusing into the extravascular space as an index of local endothelial permeability. The method can also be extended by labeling nano-particles (e.g., used to selectively...
attach to cancer cells) with a lanthanide element which can be readily detected and identified by its K-edge signature. Preliminary data and progress in manufacturing experience suggest that technical challenges can be overcome.

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5. REFERENCES


